

# **I/O Workload Characterization**

**Zachary Kurmas -- Georgia Tech**

**kurmasz@cc.gatech.edu**

**Kim Keeton -- HP Labs**

**kkeeton@hpl.hp.com**

**Ralph Becker-Szendy -- HP Labs**

## **Motivation**

- In traces, the ratio of information to bits is low
  - Traces contain much more data than most people need
- The essence of workload characterization:
  - Determine what information people need
  - Figure out how to represent it
  - Verify that the characterization does, in fact, capture all the important information

## Characterization for SSP

- SSP at HP is researching how to optimally configure storage systems for best (cost-effective) performance
  - | Would like an analytic model to predict performance for different configurations
  - | Would like a concise input for this model
  - | "Information" is the data in the trace that affects performance

## Introduction

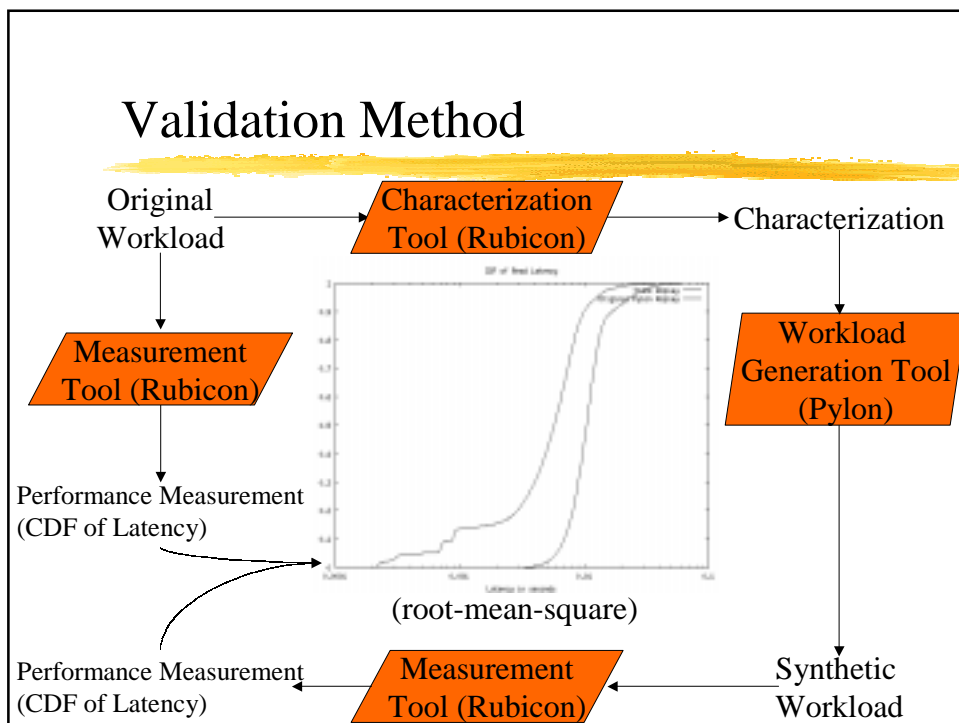
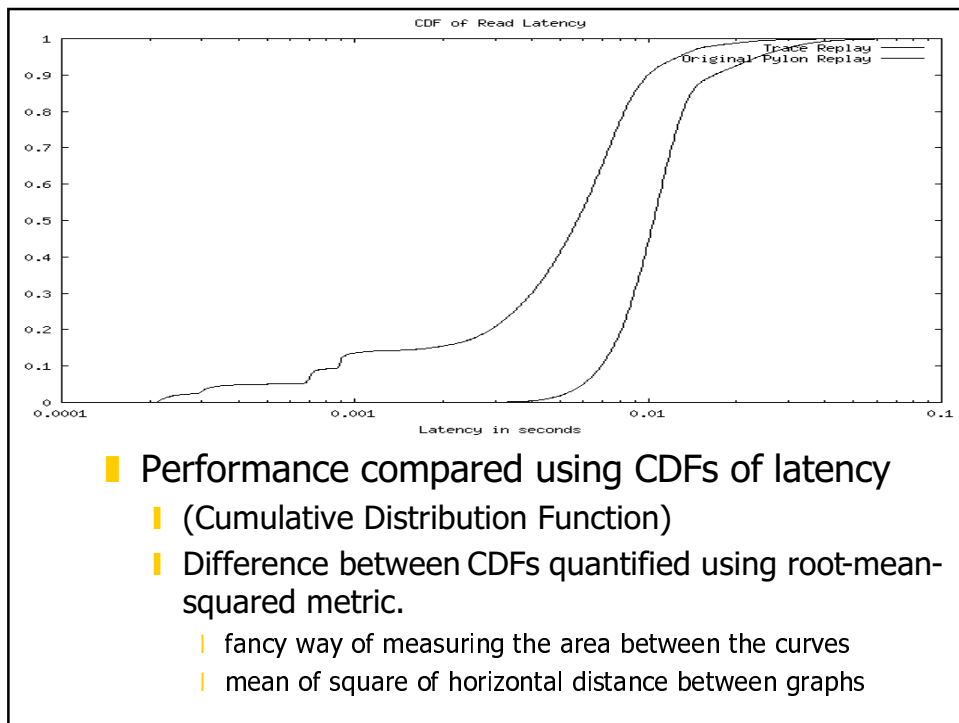
- We are developing an iterative method by which we learn how to characterize workloads
  - We are able to easily
    - | Test the quality of the characterization
    - | Isolate the effects of individual characteristics
      - to determine which information is missing
    - | Add missing information to the characterizations

## Roadmap

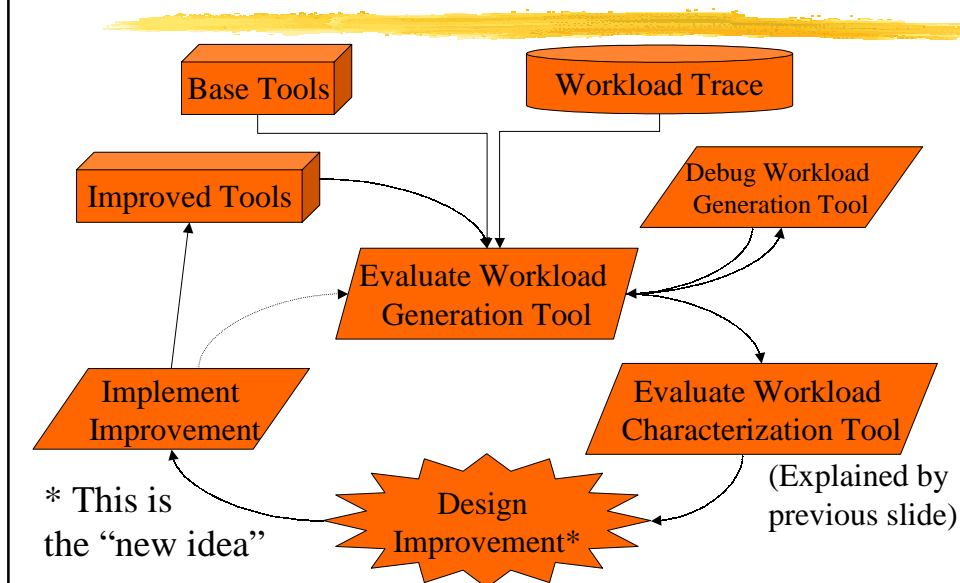
- Motivation and Introduction
- Description of Method
- Results from first 3 iterations
- Future Work
- Related Work
- Conclusions

## Verification

- How do we know if we have enough information?
  - If any workload with the same characterization has the same performance (latencies)
  - If we can generate another workload with the same performance



## Iterative Process



## Characterizing Performance

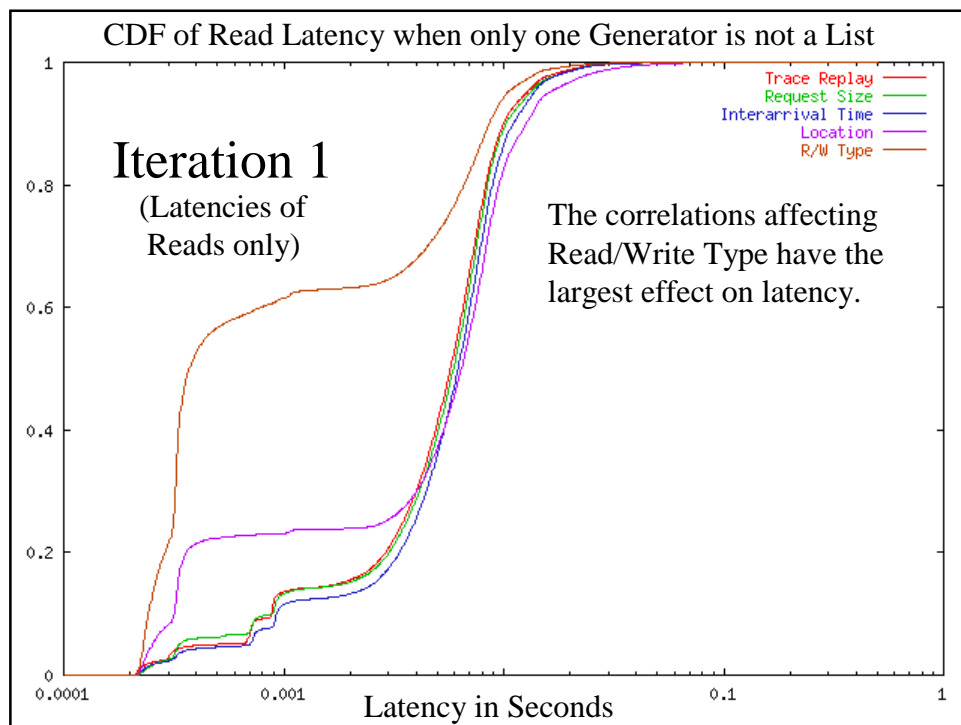
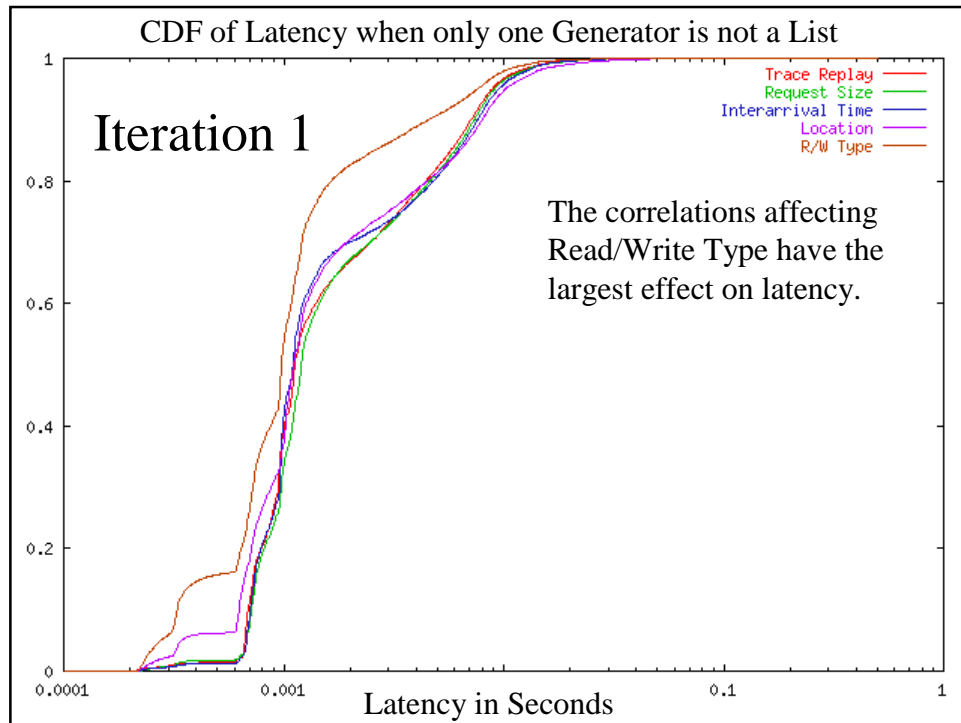
- Each I/O Request has four parameters:
  - Location, Request Size, Type (Read/Write), and Interarrival Time
- A workload is a sequence of requests
- Performance of a workload is determined by
  - Distribution of values for each parameter
  - Correlations within and between parameters' values
- "Useful" characterization must describe all "important" distributions and correlations

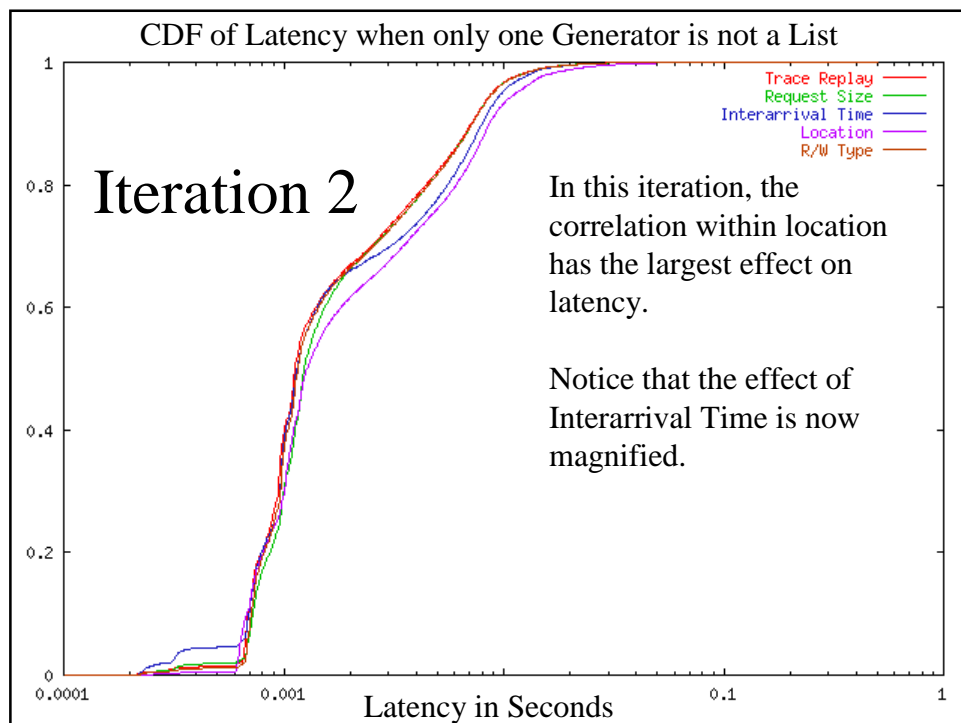
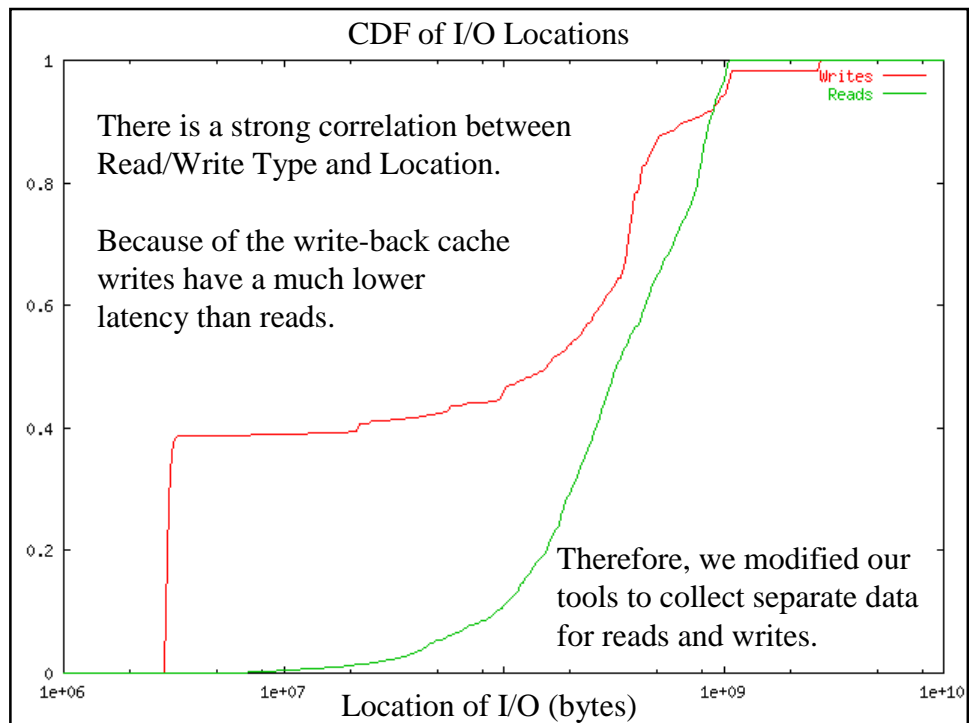
## Workload Generator

- The workload generator chooses values for each parameter separately.
  - If the generator chooses values by reading them from the trace of the original workload, then the synthetic trace is the same as the original.
  - By reading some parameters from this list (thus, holding them “constant”) and choosing other values randomly, we can remove some correlations, and thus, test their importance.

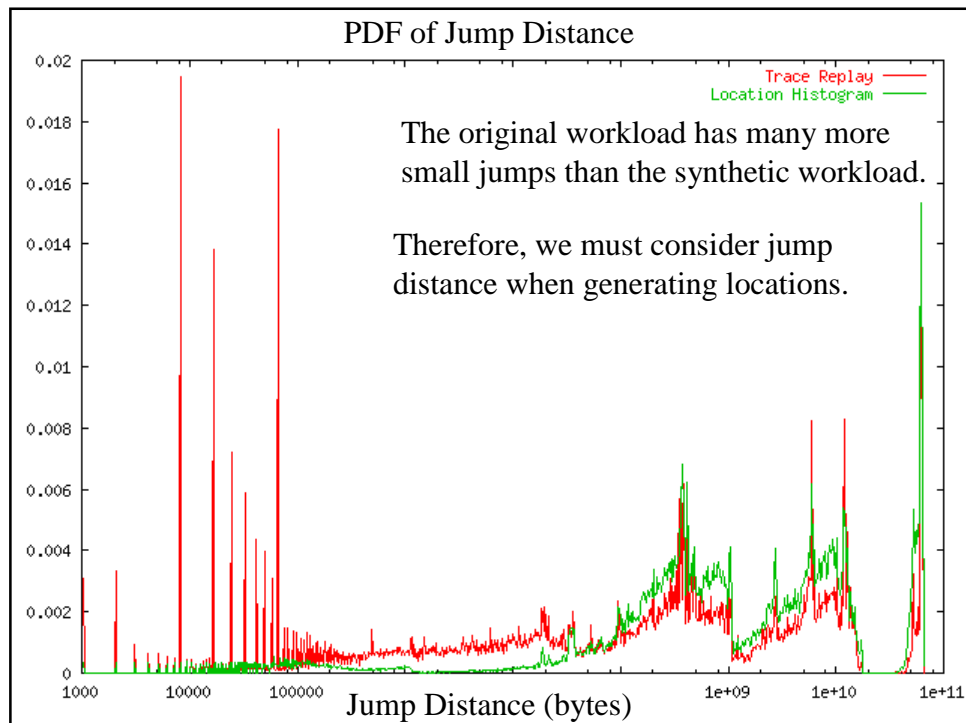
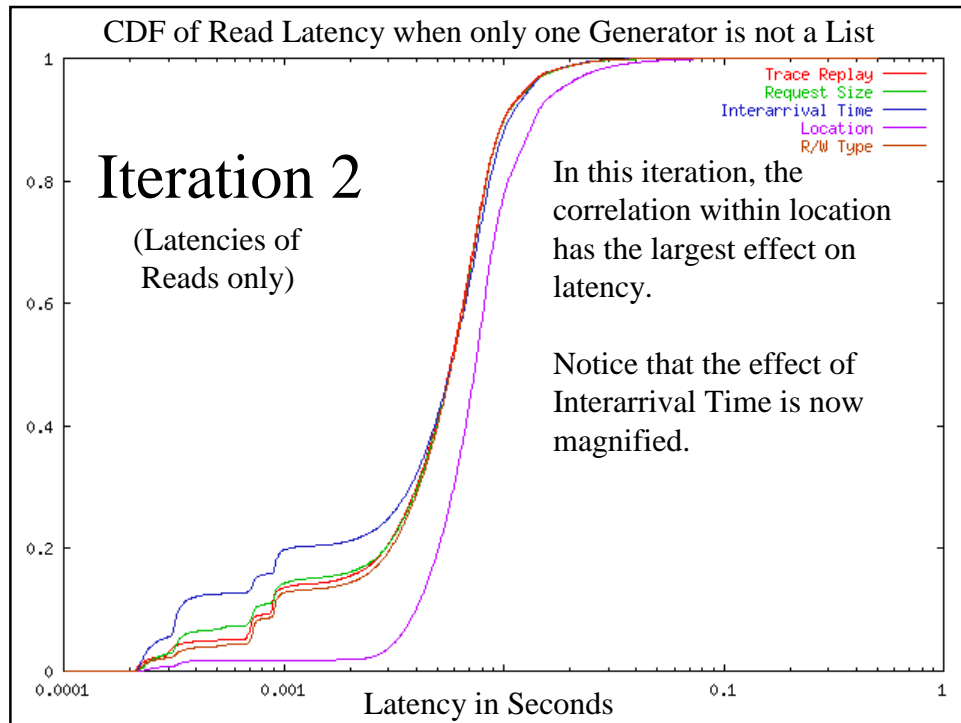
## Research Environment

- Workload: Trace of Open Mail
  - e-mail application for 15,000 users
  - Mean request rate: 75.52 I/Os per second
  - Mean request size: 7115 bytes
  - Mean throughput: 524.5KB per second
- Storage System: Optimus disk array
  - Max I/Os per second: about 100
  - Write-back cache
    - Thus, writes are “free”









## Jump Distance

- Two simple and naive attempts failed:
  - Choosing location based on a distribution of jump distance rather than location; and
  - Choosing a specified percentage of locations from the jump distance distribution and the rest from the location distribution.
- Because many threads are writing to each disk, we suspect that a per-process jump distance does not accurately account for the observed spatial locality.

## Future Work

- Develop a better method of generating locations
- We suspect that Interarrival Time/ burstiness will be the next big issue.
  - Much other research in this area
- Test our method on many different workloads

## Related Work

- Many people have studied one or two parameters:
  - Ganger -- Location and Interarrival Time
  - Faloutsos -- Interarrival Time / Burstiness
  - Gomez and Santonja -- Location
- We will consider how to incorporate these results into our framework.

## Conclusions

- We presented a new methodology for characterizing a workload.
- Using this methodology we can easily
  - Verify that the characterization has captured all the "important" information
  - Isolate the effects of individual parameters
    - and decide where to make improvements
  - Improve the characterization